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## Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

Email & Skype: info@chipsmall.com Web: www.chipsmall.com

Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China



# 74LV165

## 8-bit parallel-in/serial-out shift register

Rev. 6 — 19 February 2014

Product data sheet

### 1. General description

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The 74LV165 is an 8-bit parallel-load or serial-in shift register with complementary serial outputs ( $Q_7$  and  $\overline{Q_7}$ ) available from the last stage. When the parallel-load input ( $\overline{PL}$ ) is LOW, parallel data from the inputs D0 to D7 are loaded into the register asynchronously. When input  $\overline{PL}$  is HIGH, data enters the register serially at the input DS. It shifts one place to the right ( $Q_0 \rightarrow Q_1 \rightarrow Q_2$ , etc.) with each positive-going clock transition. This feature allows parallel-to-serial converter expansion by tying the output  $Q_7$  to the input DS of the succeeding stage.

The clock input is a gate-OR structure which allows one input to be used as an active LOW clock enable input ( $\overline{CE}$ ) input. The pin assignment for the inputs CP and  $\overline{CE}$  is arbitrary and can be reversed for layout convenience. The LOW-to-HIGH transition of the input  $\overline{CE}$  should only take place while CP HIGH for predictable operation. Either the CP or the  $\overline{CE}$  should be HIGH before the LOW-to-HIGH transition of  $\overline{PL}$  to prevent shifting the data when PL is activated.

### 2. Features and benefits

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- Wide supply voltage range from 1.0 V to 5.5 V
- Synchronous parallel-to-serial applications
- Optimized for low voltage applications: 1.0 V to 3.6 V
- Synchronous serial input for easy expansion
- Latch-up performance exceeds 250 mA
- 5.5 V tolerant inputs/outputs
- Direct interface with TTL levels (2.7 V to 3.6 V)
- Power-down mode
- Complies with JEDEC standards:
  - ◆ JESD8-5 (2.3 V to 2.7 V)
  - ◆ JESD8B/JESD36 (2.7 V to 3.6 V)
  - ◆ JESD8-1A (4.5 V to 5.5 V)
- ESD protection:
  - ◆ HBM JESD22-A114-A exceeds 2000 V
  - ◆ MM JESD22-A115-A exceeds 200 V
- Specified from  $-40\text{ }^{\circ}\text{C}$  to  $+85\text{ }^{\circ}\text{C}$  and from  $-40\text{ }^{\circ}\text{C}$  to  $+125\text{ }^{\circ}\text{C}$



### 3. Ordering information

Table 1. Ordering information

Type number	Package			Version
	Temperature range	Name	Description	
74LV165N	-40 °C to +125 °C	DIP16	plastic dual in-line package; 16 leads (300 mil)	SOT38-4
74LV165D	-40 °C to +125 °C	SO16	plastic small outline package; 16 leads; body width 3.9 mm	SOT109-1
74LV165DB	-40 °C to +125 °C	SSOP16	plastic shrink small outline package; 16 leads; body width 5.3 mm	SOT338-1
74LV165PW	-40 °C to +125 °C	TSSOP16	plastic thin shrink small outline package; 16 leads; body width 4.4 mm	SOT403-1

### 4. Functional diagram

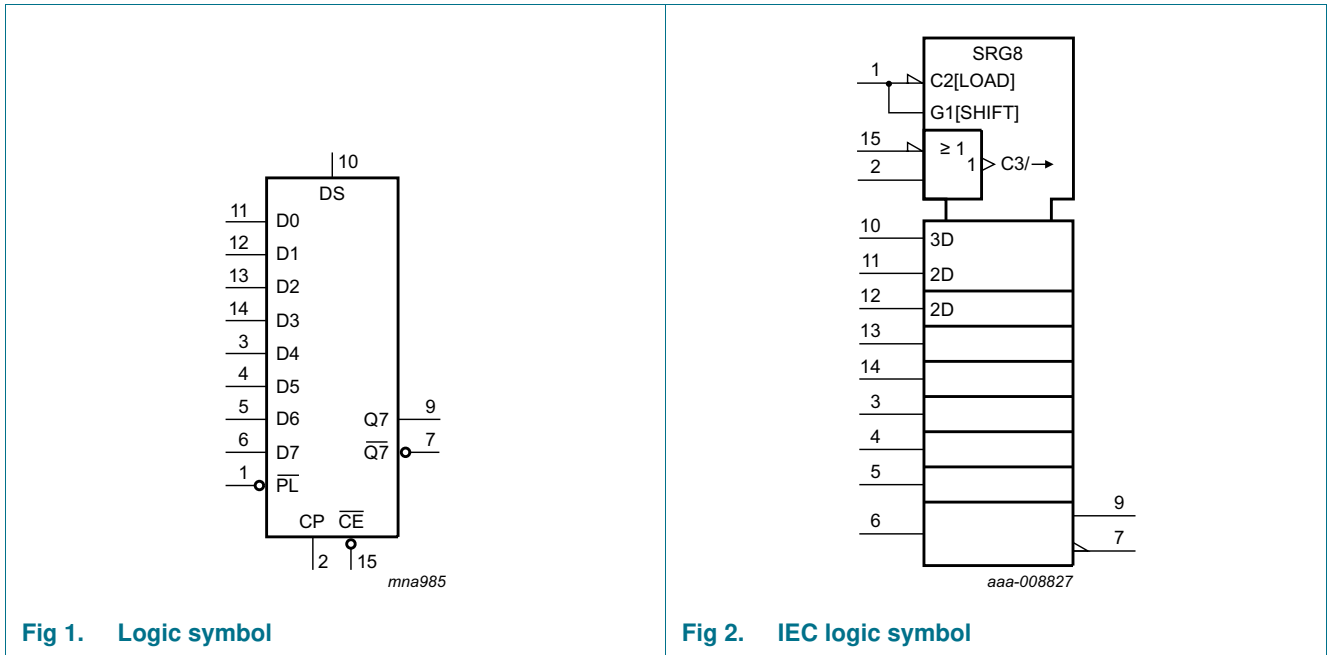


Fig 1. Logic symbol

Fig 2. IEC logic symbol

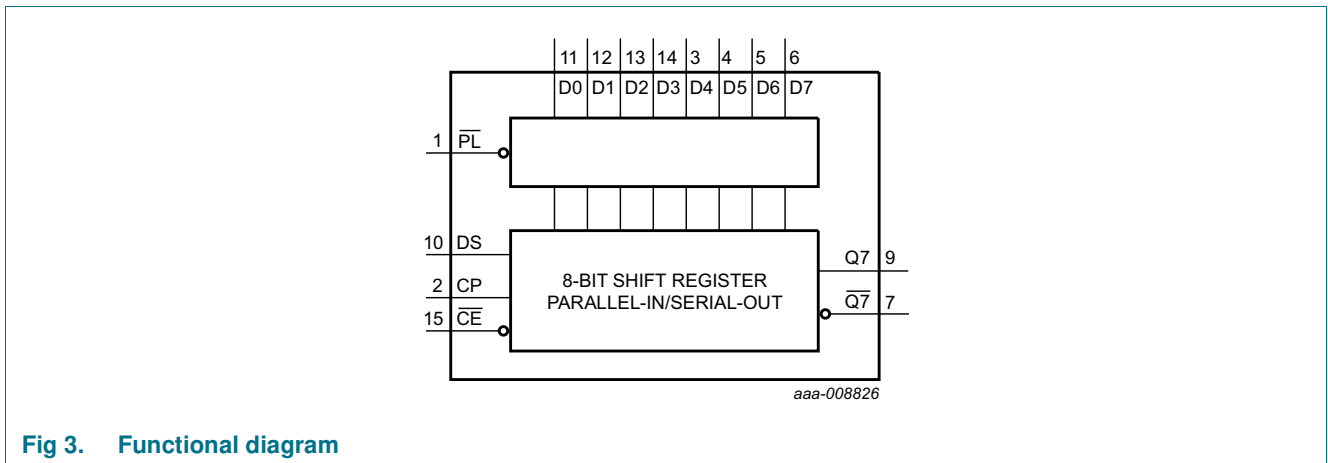
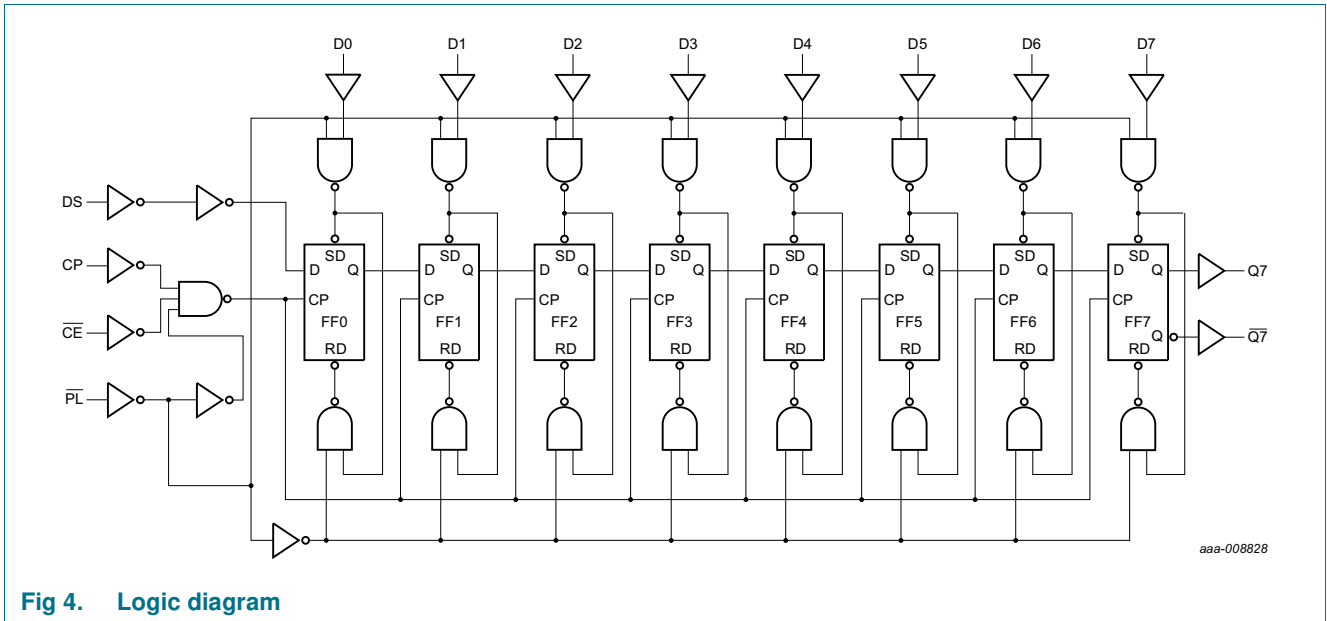
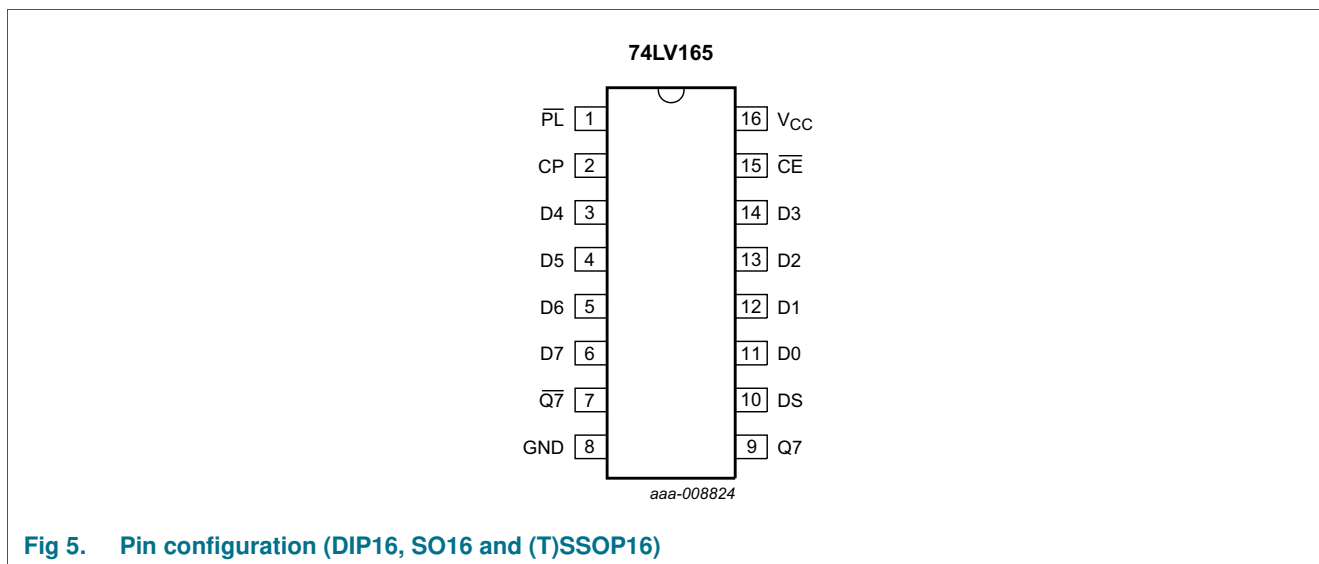


Fig 3. Functional diagram



## 5. Pinning information

### 5.1 Pinning



### 5.2 Pin description

**Table 2. Pin description**

Symbol	Pin	Description
$\overline{\text{PL}}$	1	parallel enable input (active LOW)
CP	2	clock input (LOW-to-HIGH edge-triggered)
$\overline{\text{Q7}}$	7	complementary serial output from the last stage
GND	8	ground (0 V)
Q7	9	serial output from the last stage
DS	10	serial data input
D0 to D7	11, 12, 13, 14, 3, 4, 5, 6	parallel data inputs
$\overline{\text{CE}}$	15	clock enable input (active LOW)
$V_{\text{CC}}$	16	positive supply voltage

## 6. Functional description

Table 3. Function table<sup>[1]</sup>

Operating modes	Inputs					Qn registers		Output	
	PL	CE	CP	DS	D0 to D7	Q0	Q1 to Q6	Q7	Q7
parallel load	L	X	X	X	L	L	L to L	L	H
	L	X	X	X	H	H	H to H	H	L
serial shift	H	L	↑	l	X	L	q0 to q5	q6	q6
	H	L	↑	h	X	H	q0 to q5	q6	q6
hold "do nothing"	H	H	X	X	X	q0	q1 to q6	q7	q7

- [1] H = HIGH voltage level;  
 h = HIGH voltage level one set-up time prior to the LOW-to-HIGH clock transition;  
 L = LOW voltage level;  
 l = LOW voltage level one set-up time prior to the LOW-to-HIGH clock transition;  
 q = state of the referenced output one set-up time prior to the LOW-to-HIGH clock transition;  
 X = don't care;  
 ↑ = LOW-to-HIGH clock transition.

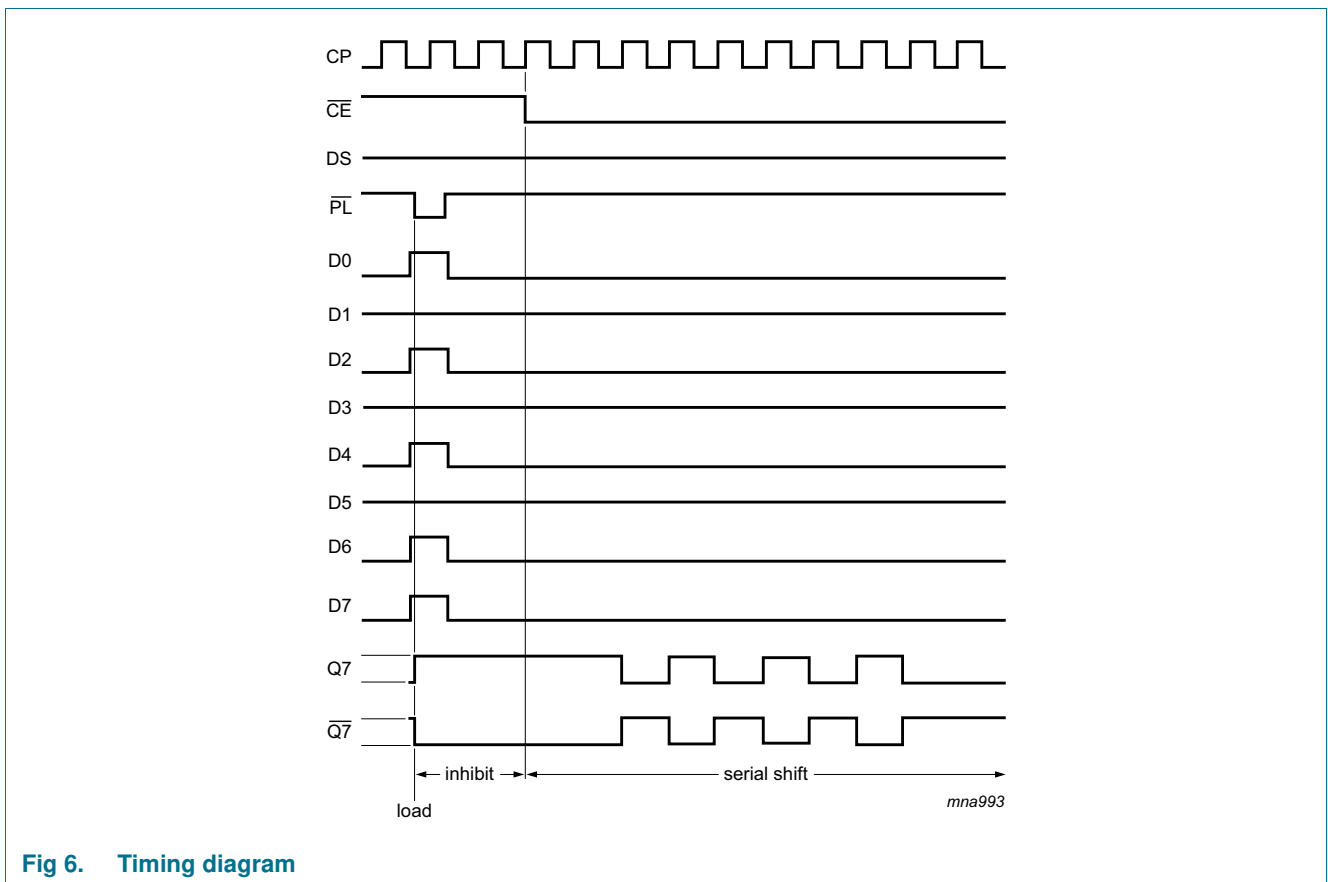


Fig 6. Timing diagram

## 7. Limiting values

**Table 4. Limiting values**

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V)<sup>[1]</sup>

Symbol	Parameter	Conditions	Min	Max	Unit
V <sub>CC</sub>	supply voltage		-0.5	+7	V
I <sub>IK</sub>	input clamping current	V <sub>I</sub> < -0.5 V or V <sub>I</sub> > V <sub>CC</sub> + 0.5 V	-	20	mA
V <sub>I</sub>	input voltage		-0.5	+7	V
I <sub>OK</sub>	output clamping current	V <sub>O</sub> > V <sub>CC</sub> or V <sub>O</sub> < 0	-	±50	mA
I <sub>O</sub>	output current	-0.5 V < V <sub>O</sub> < V <sub>CC</sub> + 0.5 V	-	±25	mA
I <sub>CC</sub>	supply current		-	+50	mA
I <sub>GND</sub>	ground current		-50	-	mA
T <sub>stg</sub>	storage temperature		-65	+150	°C
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> = -40 °C to +125 °C			
		DIP16 package	<sup>[2]</sup> -	750	mW
		SO16 package	<sup>[3]</sup> -	500	mW
		(T)SSOP16 package	<sup>[4]</sup> -	400	mW

[1] The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

[2] P<sub>tot</sub> derates linearly with 12 mW/K above 70 °C.

[3] P<sub>tot</sub> derates linearly with 8 mW/K above 70 °C.

[4] P<sub>tot</sub> derates linearly with 5.5 mW/K above 60 °C.

## 8. Recommended operating conditions

**Table 5. Recommended operating conditions**

Voltages are referenced to GND (ground = 0 V)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V <sub>CC</sub>	supply voltage		1.0	3.3	5.5	V
V <sub>I</sub>	input voltage		0	-	V <sub>CC</sub>	V
V <sub>O</sub>	output voltage		0	-	V <sub>CC</sub>	V
T <sub>amb</sub>	ambient temperature		-40	-	+85	°C
Δt/ΔV	input transition rise and fall rate	V <sub>CC</sub> = 1.0 V to 2.0 V	0	-	500	ns/V
		V <sub>CC</sub> = 2.0 V to 2.7 V	0	-	200	ns/V
		V <sub>CC</sub> = 2.7 V to 3.6 V	0	-	100	ns/V
		V <sub>CC</sub> = 3.6 V to 5.5 V	0	-	50	ns/V

## 9. Static characteristics

**Table 6. Static characteristics**

At recommended operating conditions; voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	-40 °C to +85 °C			-40 °C to +125 °C		Unit	
			Min	Typ <sup>[1]</sup>	Max	Min	Max		
V <sub>IH</sub>	HIGH-level input voltage	V <sub>CC</sub> = 1.2 V	0.9	-	-	0.9	-	V	
		V <sub>CC</sub> = 2.3 V to 2.7 V	1.4	-	-	1.4	-	V	
		V <sub>CC</sub> = 2.7 V to 3.6 V	2.0	-	-	2.0	-	V	
		V <sub>CC</sub> = 4.5 V to 5.5 V	0.7V <sub>CC</sub>	-	-	0.7V <sub>CC</sub>	-	V	
V <sub>IL</sub>	LOW-level input voltage	V <sub>CC</sub> = 1.2 V	-	-	0.3	-	0.3	V	
		V <sub>CC</sub> = 2.3 V to 2.7 V	-	-	0.6	-	0.6	V	
		V <sub>CC</sub> = 2.7 V to 3.6 V	-	-	0.8	-	0.8	V	
		V <sub>CC</sub> = 4.5 V to 5.5 V	-	-	0.3V <sub>CC</sub>	-	0.3V <sub>CC</sub>		
V <sub>OH</sub>	HIGH-level output voltage	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; I <sub>O</sub> = -100 μA							
		V <sub>CC</sub> = 1.2 V	-	1.2	-	-	-		
		V <sub>CC</sub> = 2.0 V	1.8	2.0	-	1.8	-	V	
		V <sub>CC</sub> = 2.7 V	2.5	2.7	-	2.5	-	V	
		V <sub>CC</sub> = 3.0 V	2.8	3.0	-	2.8	-	V	
		V <sub>CC</sub> = 4.5 V	4.3	4.5	-	4.3	-	V	
		standard outputs: V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub>							
		V <sub>CC</sub> = 3.0 V; I <sub>O</sub> = -6 mA	2.40	2.82	-	2.20	-	V	
V <sub>CC</sub> = 4.5 V; I <sub>O</sub> = -12 mA	3.60	4.20	-	3.50	-	V			
V <sub>OL</sub>	LOW-level output voltage	V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub> ; I <sub>O</sub> = 100 μA							
		V <sub>CC</sub> = 1.2 V	-	0	-	-	-		
		V <sub>CC</sub> = 2.0 V	-	0	0.2	1.8	0.2	V	
		V <sub>CC</sub> = 2.7 V	-	0	0.2	2.5	0.2	V	
		V <sub>CC</sub> = 3.0 V	-	0	0.2	2.8	0.2	V	
		V <sub>CC</sub> = 4.5 V	-	0	0.2	4.3	0.2	V	
		standard outputs: V <sub>I</sub> = V <sub>IH</sub> or V <sub>IL</sub>							
		V <sub>CC</sub> = 3.0 V; I <sub>O</sub> = 6 mA	-	0.25	0.40	-	0.50	V	
V <sub>CC</sub> = 4.5 V; I <sub>O</sub> = 12 mA	-	0.35	0.55	-	0.65	V			
I <sub>I</sub>	input leakage current	V <sub>I</sub> = V <sub>CC</sub> or GND; V <sub>CC</sub> = 5.5 V	-	-	±1	-	±1	μA	
I <sub>CC</sub>	supply current	V <sub>I</sub> = V <sub>CC</sub> or GND; I <sub>O</sub> = 0 A; V <sub>CC</sub> = 5.5 V	-	-	20	-	160	μA	
ΔI <sub>CC</sub>	additional supply current	V <sub>I</sub> = V <sub>CC</sub> - 0.6 V; V <sub>CC</sub> = 2.7 V to 3.6 V	-	-	500	-	850	μA	
C <sub>I</sub>	input capacitance		-	3.5	-			pF	

[1] Typical values are measured at T<sub>amb</sub> = 25 °C.



## 10. Dynamic characteristics

**Table 7. Dynamic characteristics**
*GND (ground = 0 V); for test circuit, see [Figure 12](#)*

Symbol	Parameter	Conditions	-40 °C to +85 °C			-40 °C to +125 °C		Unit	
			Min	Typ <sup>[1]</sup>	Max	Min	Max		
t <sub>pd</sub>	propagation delay	CE, CP to Q7, $\overline{Q7}$ ; see <a href="#">Figure 7</a> and <a href="#">Figure 8</a>		<a href="#">[2]</a>					
		V <sub>CC</sub> = 1.2 V	-	115	-	-	-	ns	
		V <sub>CC</sub> = 2.0 V	-	38	61	-	76	ns	
		V <sub>CC</sub> = 2.7 V	-	27	43	-	54	ns	
		V <sub>CC</sub> = 3.0 V to 3.6 V	<a href="#">[3]</a>	22	36	-	45	ns	
		V <sub>CC</sub> = 3.3 V; C <sub>L</sub> = 15 pF		18	-	-	-	ns	
		V <sub>CC</sub> = 4.5 V to 5.5 V	<a href="#">[4]</a>	15	24	-	30	ns	
		$\overline{PL}$ to Q7, $\overline{Q7}$ ; see <a href="#">Figure 8</a>							
		V <sub>CC</sub> = 1.2 V	-	110	-	-	-	ns	
		V <sub>CC</sub> = 2.0 V	-	35	56	-	70	ns	
		V <sub>CC</sub> = 2.7 V	-	24	39	-	49	ns	
		V <sub>CC</sub> = 3.0 V to 3.6 V	<a href="#">[3]</a>	20	33	-	41	ns	
		V <sub>CC</sub> = 3.3 V; C <sub>L</sub> = 15 pF		18	-	-	-	ns	
		V <sub>CC</sub> = 4.5 V to 5.5 V	<a href="#">[4]</a>	14	22	-	27	ns	
		D7 to Q7, $\overline{Q7}$ ; C <sub>L</sub> = 15 pF; see <a href="#">Figure 9</a>							
		V <sub>CC</sub> = 1.2 V	-	90	-	-	-	ns	
		V <sub>CC</sub> = 2.0 V	-	28	45	-	56	ns	
		V <sub>CC</sub> = 2.7 V	-	20	32	-	40	ns	
		V <sub>CC</sub> = 3.0 V to 3.6 V	<a href="#">[3]</a>	17	27	-	33	ns	
		V <sub>CC</sub> = 3.3 V; C <sub>L</sub> = 15 pF		14	-	-	-	ns	
		V <sub>CC</sub> = 4.5 V to 5.5 V	<a href="#">[4]</a>	11	18	-	22	ns	
t <sub>w</sub>	pulse width	CP input HIGH to LOW; see <a href="#">Figure 7</a>							
		V <sub>CC</sub> = 2.0 V	34	10	-	41	-	ns	
		V <sub>CC</sub> = 2.7 V	25	8	-	30	-	ns	
		V <sub>CC</sub> = 3.0 V to 3.6 V	<a href="#">[3]</a>	20	7	-	24	-	ns
		V <sub>CC</sub> = 4.5 V to 5.5 V	<a href="#">[4]</a>	15	5	-	18	-	ns
		$\overline{PL}$ input LOW; see <a href="#">Figure 8</a>							
		V <sub>CC</sub> = 2.0 V	34	10	-	41	-	ns	
		V <sub>CC</sub> = 2.7 V	25	8	-	30	-	ns	
		V <sub>CC</sub> = 3.0 V to 3.6 V	<a href="#">[3]</a>	20	7	-	24	-	ns
		V <sub>CC</sub> = 4.5 V to 5.5 V	<a href="#">[4]</a>	15	5	-	18	-	ns

**Table 7. Dynamic characteristics ...continued**  
 GND (ground = 0 V); for test circuit, see [Figure 12](#)

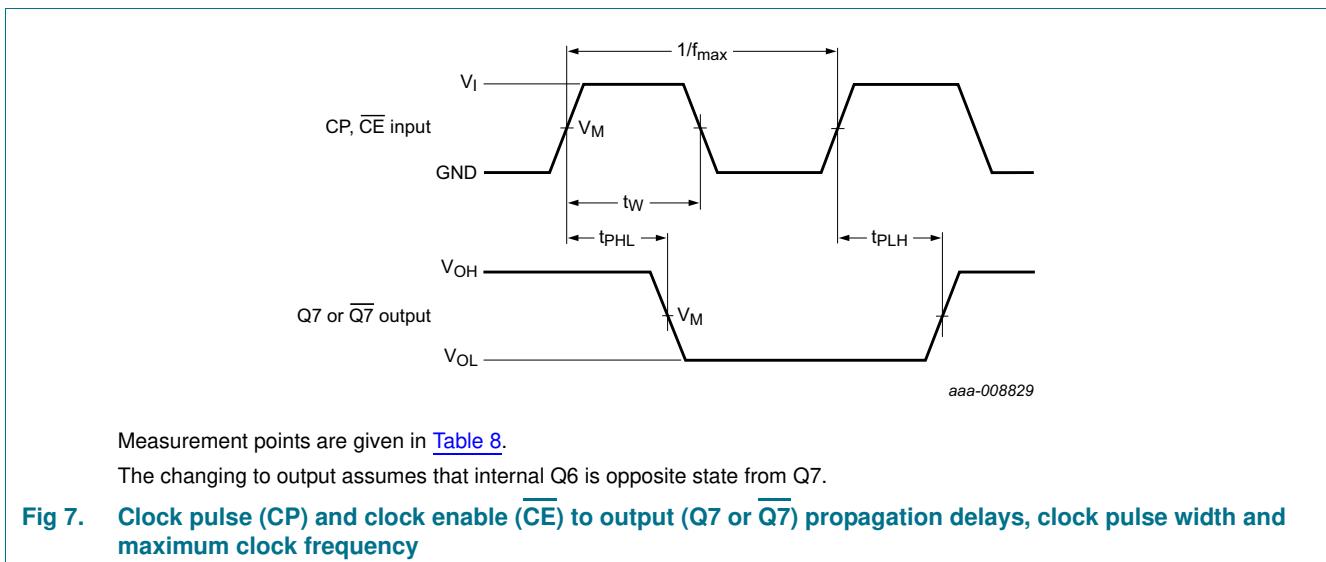
Symbol	Parameter	Conditions	-40 °C to +85 °C			-40 °C to +125 °C		Unit		
			Min	Typ <sup>[1]</sup>	Max	Min	Max			
t <sub>rec</sub>	recovery time	$\overline{PL}$ to CP, $\overline{CE}$ ; see <a href="#">Figure 8</a>								
		V <sub>CC</sub> = 1.2 V	-	40	-	-	-	ns		
		V <sub>CC</sub> = 2.0 V	24	15	-	30	-	ns		
		V <sub>CC</sub> = 2.7 V	18	11	-	23	-	ns		
		V <sub>CC</sub> = 3.0 V to 3.6 V <sup>[3]</sup>	17	10	-	21	-	ns		
		V <sub>CC</sub> = 4.5 V to 5.5 V <sup>[4]</sup>	12	7	-	15	-	ns		
t <sub>su</sub>	set-up time	DS to CP, $\overline{CE}$ ; see <a href="#">Figure 10</a>								
		V <sub>CC</sub> = 1.2 V	-	-8	-	-	-	ns		
		V <sub>CC</sub> = 2.0 V	22	-2	-	26	-	ns		
		V <sub>CC</sub> = 2.7 V	16	-1	-	19	-	ns		
		V <sub>CC</sub> = 3.0 V to 3.6 V <sup>[3]</sup>	13	-1	-	15	-	ns		
		V <sub>CC</sub> = 4.5 V to 5.5 V <sup>[4]</sup>	9	0	-	10	-	ns		
		$\overline{CE}$ to CP, CP to $\overline{CE}$ ; see <a href="#">Figure 10</a>								
		V <sub>CC</sub> = 1.2 V	-	20	-	-	-	ns		
		V <sub>CC</sub> = 2.0 V	22	7	-	26	-	ns		
		V <sub>CC</sub> = 2.7 V	16	5	-	19	-	ns		
		V <sub>CC</sub> = 3.0 V to 3.6 V <sup>[3]</sup>	13	4	-	15	-	ns		
		V <sub>CC</sub> = 4.5 V to 5.5 V <sup>[4]</sup>	9	3	-	10	-	ns		
		Dn to $\overline{PL}$ ; see <a href="#">Figure 11</a>								
		V <sub>CC</sub> = 1.2 V	-	25	-	-	-	ns		
		V <sub>CC</sub> = 2.0 V	22	8	-	26	-	ns		
		V <sub>CC</sub> = 2.7 V	16	6	-	19	-	ns		
		V <sub>CC</sub> = 3.0 V to 3.6 V <sup>[3]</sup>	13	5	-	15	-	ns		
		V <sub>CC</sub> = 4.5 V to 5.5 V <sup>[4]</sup>	9	4	-	10	-	ns		
		t <sub>h</sub>	hold time	DS to CP, $\overline{CE}$ ; Dn to $\overline{PL}$ ; see <a href="#">Figure 10</a> and <a href="#">Figure 11</a>						
				V <sub>CC</sub> = 1.2 V	-	20	-	-	-	ns
V <sub>CC</sub> = 2.0 V	22			7	-	26	-	ns		
V <sub>CC</sub> = 2.7 V	16			5	-	19	-	ns		
V <sub>CC</sub> = 3.0 V to 3.6 V <sup>[3]</sup>	13			4	-	15	-	ns		
V <sub>CC</sub> = 4.5 V to 5.5 V <sup>[4]</sup>	9			3	-	10	-	ns		
$\overline{CE}$ to CP, CP to $\overline{CE}$ ; see <a href="#">Figure 10</a>										
V <sub>CC</sub> = 1.2 V	-			-30	-	-	-	ns		
V <sub>CC</sub> = 2.0 V	5			-8	-	5	-	ns		
V <sub>CC</sub> = 2.7 V	5			-6	-	5	-	ns		
V <sub>CC</sub> = 3.0 V to 3.6 V <sup>[3]</sup>	5			-5	-	5	-	ns		
V <sub>CC</sub> = 4.5 V to 5.5 V <sup>[4]</sup>	5			-4	-	5	-	ns		

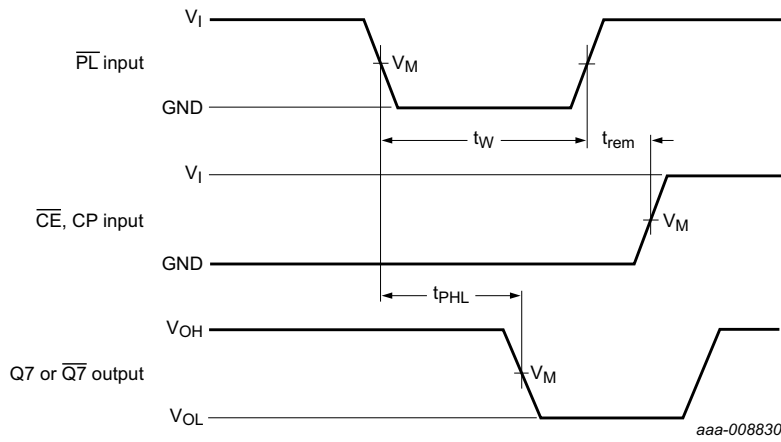
**Table 7. Dynamic characteristics ...continued**  
 GND (ground = 0 V); for test circuit, see [Figure 12](#)

Symbol	Parameter	Conditions	-40 °C to +85 °C			-40 °C to +125 °C		Unit
			Min	Typ <sup>[1]</sup>	Max	Min	Max	
f <sub>max</sub>	maximum frequency	see <a href="#">Figure 7</a>						
		V <sub>CC</sub> = 2.0 V	14	40	-	12	-	MHz
		V <sub>CC</sub> = 2.7 V	19	60	-	16	-	MHz
		V <sub>CC</sub> = 3.0 V to 3.6 V <sup>[3]</sup>	24	65	-	20	-	MHz
		V <sub>CC</sub> = 3.3 V; C <sub>L</sub> = 15 pF	-	78	-	-	-	MHz
		V <sub>CC</sub> = 4.5 V to 5.5 V <sup>[4]</sup>	36	75	-	30	-	MHz
C <sub>PD</sub>	power dissipation capacitance	V <sub>I</sub> = GND to V <sub>CC</sub> ; V <sub>CC</sub> = 3.3 V <sup>[5]</sup>	-	35	-			pF

- [1] Typical values are measured at T<sub>amb</sub> = 25 °C.
- [2] t<sub>pd</sub> is the same as t<sub>PHL</sub> and t<sub>PLH</sub>.
- [3] Typical values are measured at V<sub>CC</sub> = 3.3 V.
- [4] Typical values are measured at V<sub>CC</sub> = 5.0 V.
- [5] C<sub>PD</sub> is used to determine the dynamic power dissipation P<sub>D</sub> = C<sub>PD</sub> × V<sub>CC</sub><sup>2</sup> × f<sub>i</sub> + Σ (C<sub>L</sub> × V<sub>CC</sub><sup>2</sup> × f<sub>o</sub>) (P<sub>D</sub> in μW), where:  
 f<sub>i</sub> = input frequency in MHz;  
 f<sub>o</sub> = output frequency in MHz;  
 Σ (C<sub>L</sub> × V<sub>CC</sub><sup>2</sup> × f<sub>o</sub>) = sum of outputs;  
 C<sub>L</sub> = output load capacitance in pF;  
 V<sub>CC</sub> = supply voltage in V.

## 11. Waveforms

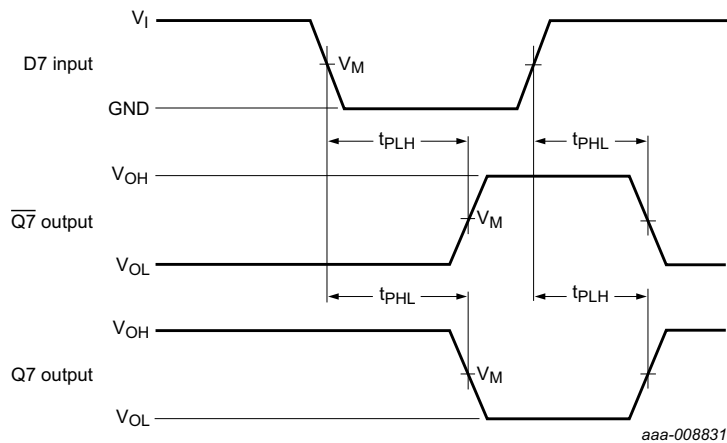




Measurement points are given in [Table 8](#).

The changing to output assumes that internal Q6 is opposite state from Q7.

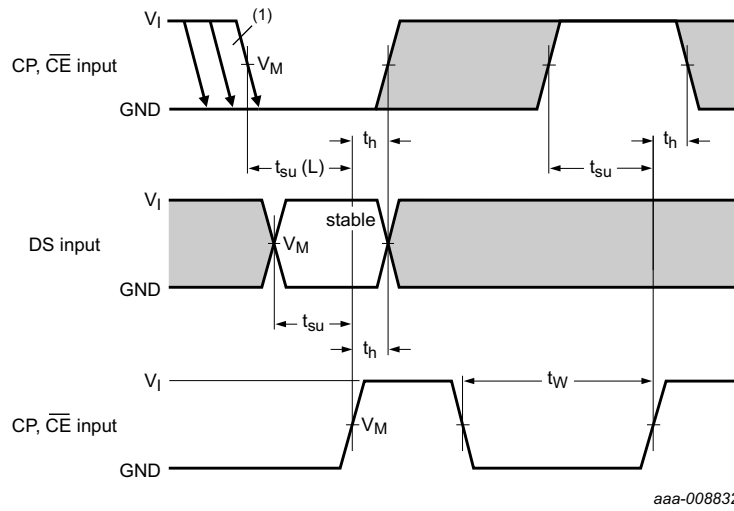
**Fig 8. Parallel load ( $\overline{PL}$ ) pulse width, parallel load to output (Q7 or  $\overline{Q7}$ ) propagation delays, parallel load to clock (CP) and clock enable ( $\overline{CE}$ ) recovery time**



Measurement points are given in [Table 8](#).

The changing to output assumes that internal Q6 is opposite state from Q7.

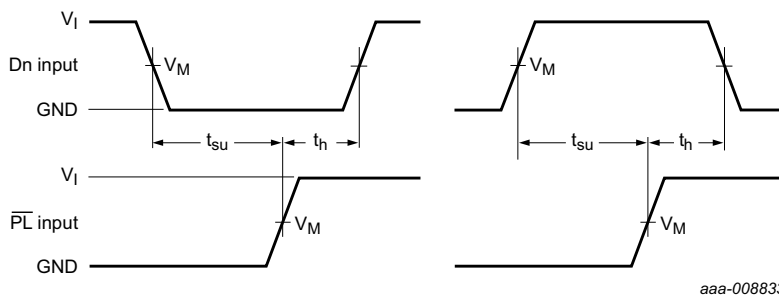
**Fig 9. Data input (Dn) to output (Q7 or  $\overline{Q7}$ ) propagation delays when  $\overline{PL}$  is LOW**



Measurement points are given in [Table 8](#).

- (1) CE may change only from HIGH-to-LOW while CP is LOW. The shaded areas indicate when the input is permitted to change for predictable output performance.

**Fig 10. Set-up and hold times**

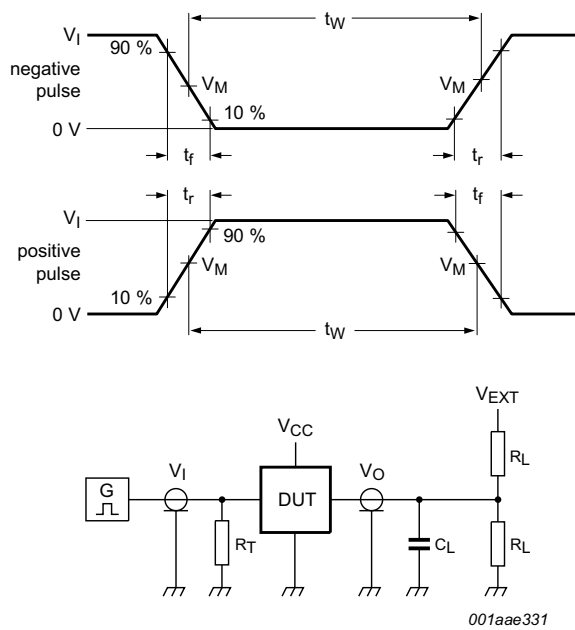


Measurement points are given in [Table 8](#).

**Fig 11. Set-up and hold times from the data inputs (Dn) to the parallel load input (PL)**

**Table 8. Measurement points**

Supply voltage	Input	Output
$V_{CC}$	$V_M$	$V_M$
< 2.7 V	$0.5V_{CC}$	$0.5V_{CC}$
2.7 V to 3.6 V	1.5 V	1.5 V
$\geq 4.5$ V	$0.5V_{CC}$	$0.5V_{CC}$



Test data is given in [Table 9](#).

Definitions for test circuit:

$R_L$  = Load resistance.

$C_L$  = Load capacitance including jig and probe capacitance.

$R_T$  = Termination resistance should be equal to output impedance  $Z_o$  of the pulse generator.

$V_{EXT}$  = External voltage for measuring switching times.

**Fig 12. Test circuit for measuring switching times**

**Table 9. Test data**

Supply voltage	Input		Load		$V_{EXT}$
	$V_I$	$t_r, t_f$	$C_L$	$R_L$	$t_{PHL}, t_{PLH}$
< 2.7 V	$V_{CC}$	2.5 ns	50 pF	1 k $\Omega$	open
2.7 V to 3.6 V	2.7 V	2.5 ns	50 pF, 15 pF	1 k $\Omega$	open
$\geq 4.5$ V	$V_{CC}$	2.5 ns	50 pF	1 k $\Omega$	open

12. Package outline

DIP16: plastic dual in-line package; 16 leads (300 mil)

SOT38-4

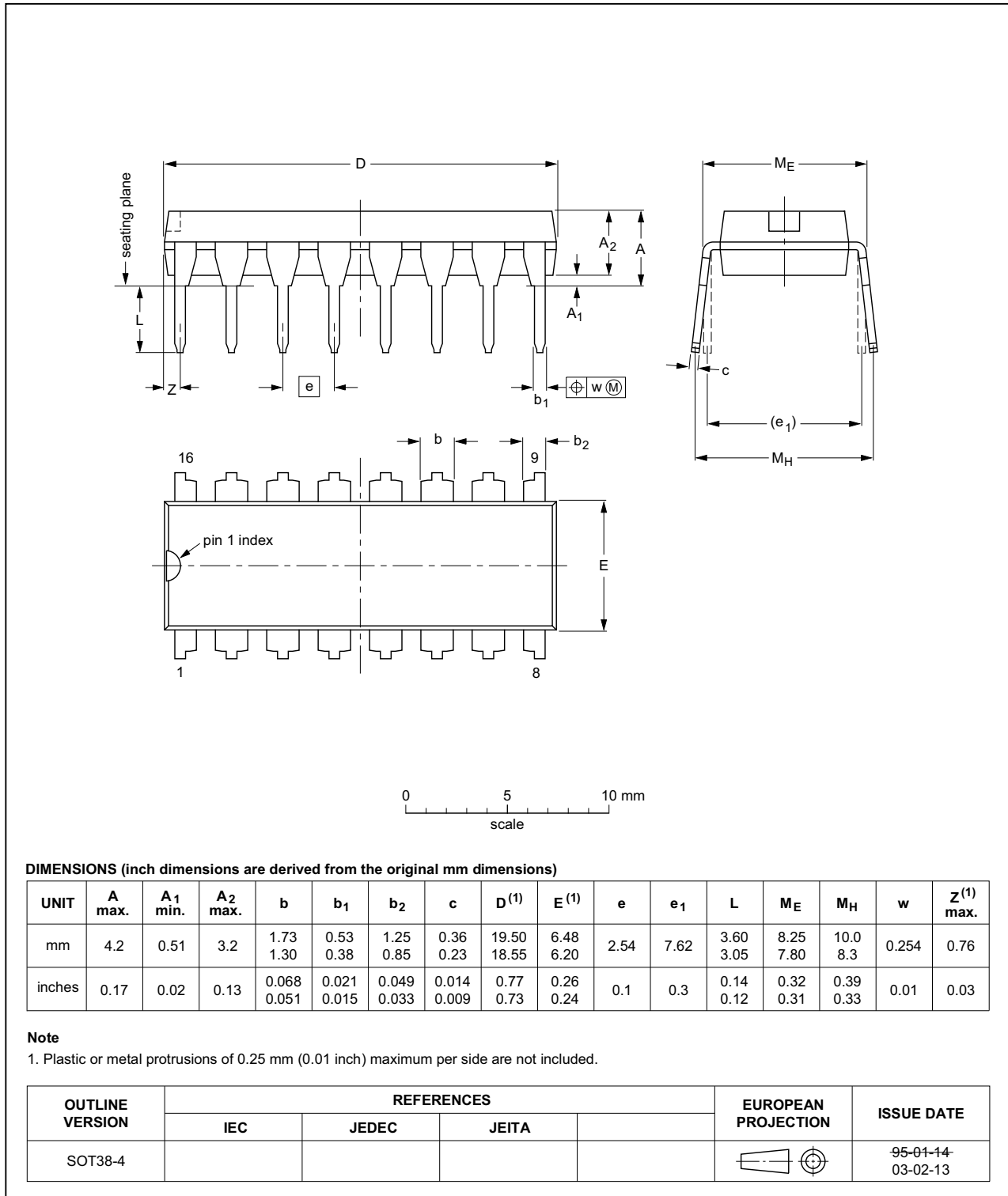


Fig 13. Package outline SOT38-4 (DIP16)

SO16: plastic small outline package; 16 leads; body width 3.9 mm

SOT109-1

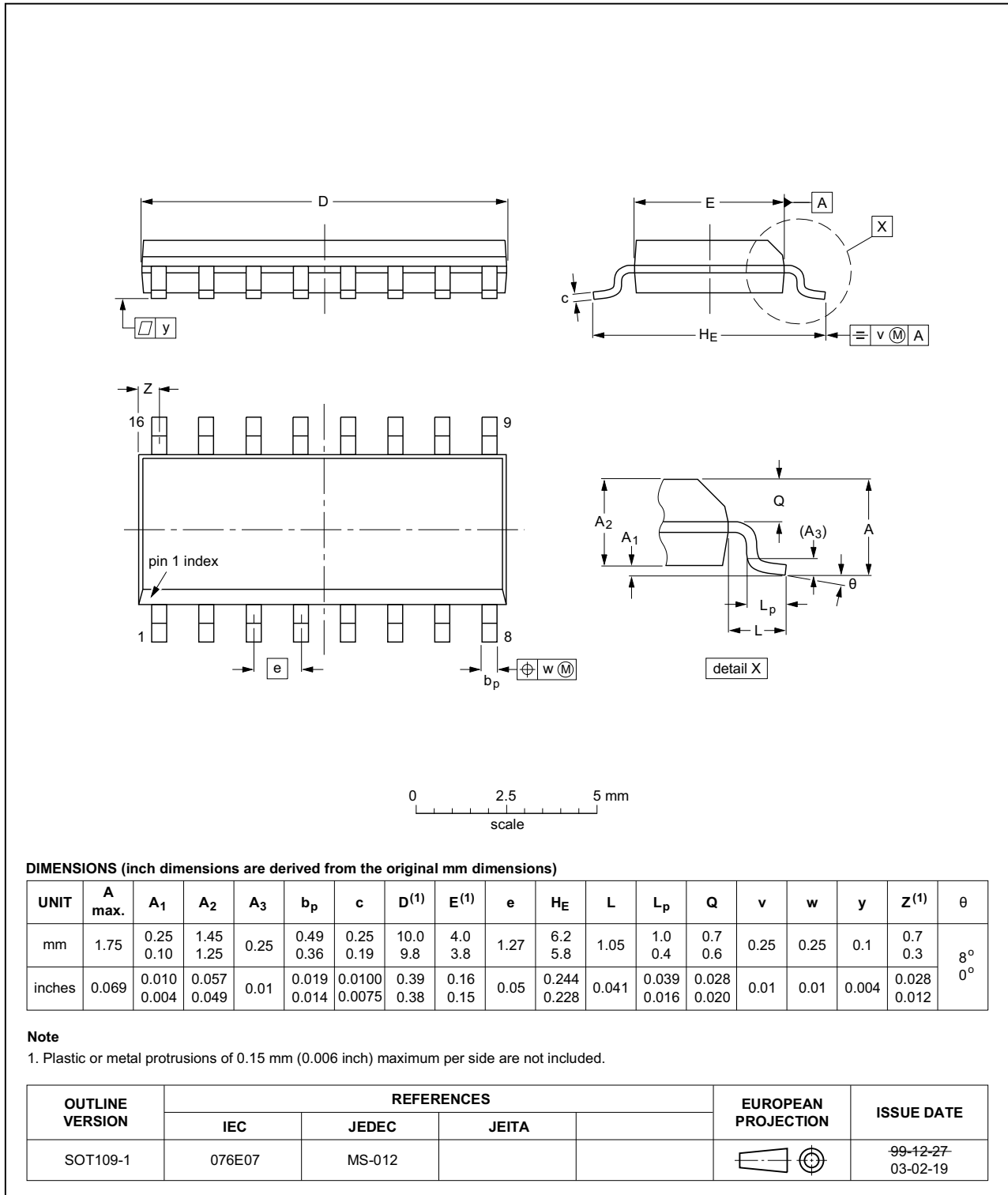


Fig 14. Package outline SOT109-1 (SO16)



SSOP16: plastic shrink small outline package; 16 leads; body width 5.3 mm

SOT338-1

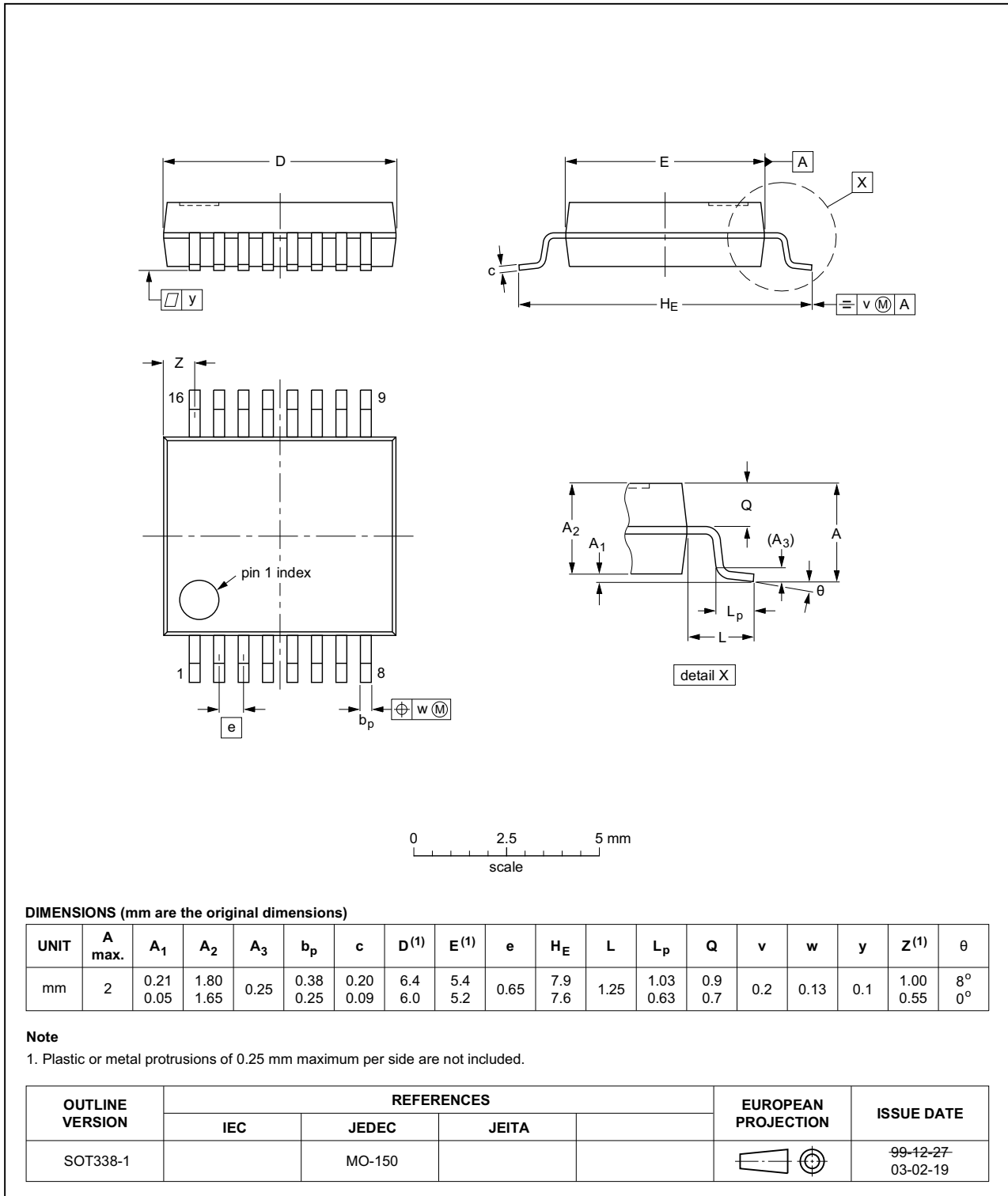


Fig 15. Package outline SOT338-1 (SSOP16)

TSSOP16: plastic thin shrink small outline package; 16 leads; body width 4.4 mm

SOT403-1

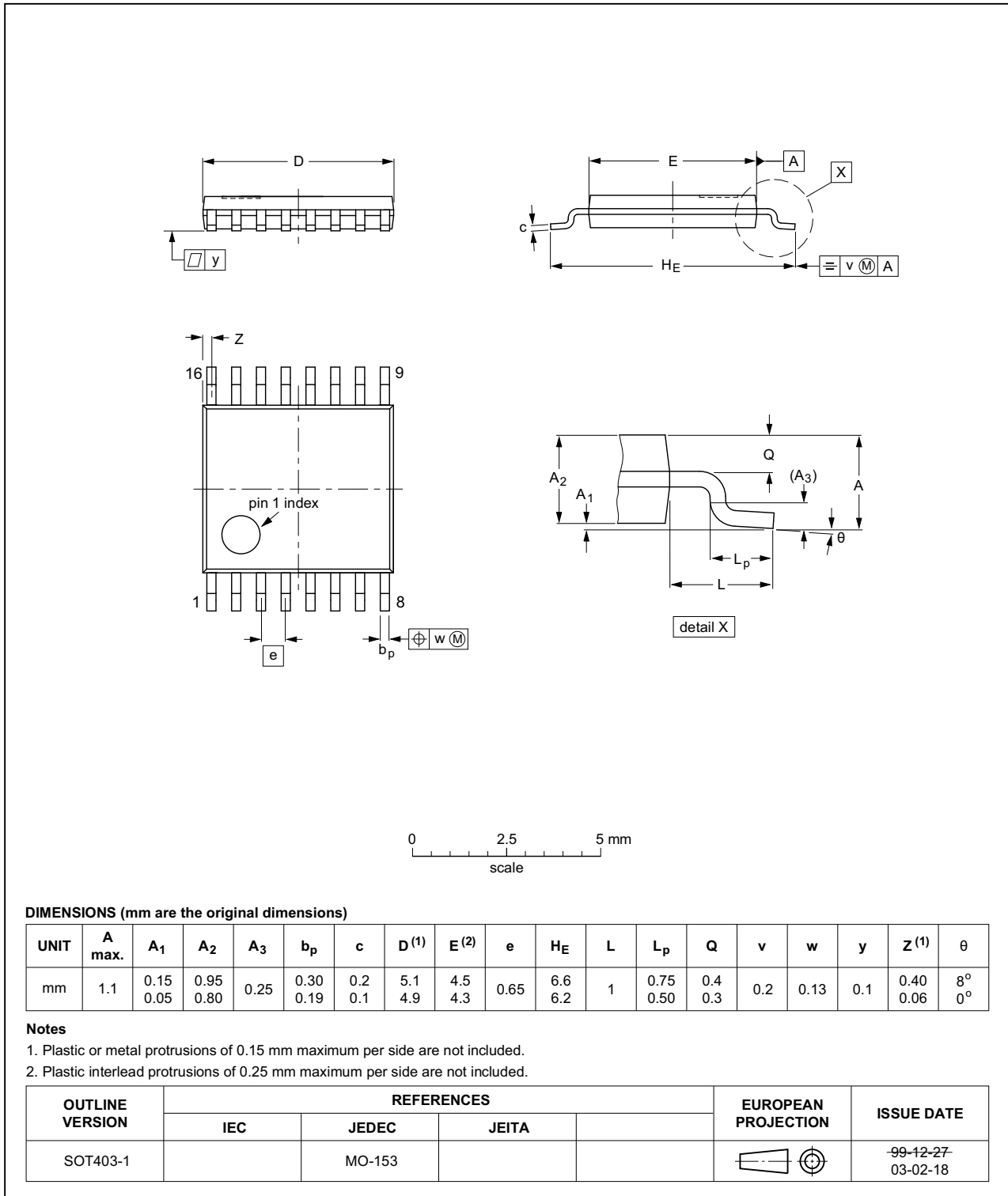


Fig 16. Package outline SOT403-1 (TSSOP16)

## 13. Abbreviations

Table 10. Abbreviations

Acronym	Description
CMOS	Complementary Metal-Oxide Semiconductor
DUT	Device Under Test
ESD	ElectroStatic Discharge
HBM	Human Body Model
MM	Machine Model
TTL	Transistor-Transistor Logic

## 14. Revision history

Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
74LV165 v.6	20140219	Product data sheet	-	74LV165 v.5
Modifications:	<ul style="list-style-type: none"> <li>• Typo corrected in <a href="#">Table 2 "Pin description"</a></li> </ul>			
74LV165 v.5	20130909	Product data sheet	-	74LV165 v.4
Modifications:	<ul style="list-style-type: none"> <li>• Typo corrected in the header of <a href="#">Table 6 "Static characteristics"</a></li> </ul>			
74LV165 v.4	20130830	Product data sheet	-	74LV165_CNV_3
Modifications:	<ul style="list-style-type: none"> <li>• The format of this data sheet has been redesigned to comply with the new identity guidelines of NXP Semiconductors.</li> <li>• Legal texts have been adapted to the new company name where appropriate.</li> <li>• Family data added, see <a href="#">Section 9 "Static characteristics"</a></li> </ul>			
74LV165_CNV_3	December 1998	Product specification	-	-

## 15. Legal information

### 15.1 Data sheet status

Document status <sup>[1][2]</sup>	Product status <sup>[3]</sup>	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

[2] The term 'short data sheet' is explained in section "Definitions".

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